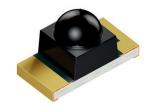
SFH 4059R

Chip LED Lens

High Power Infrared Emitter (850 nm)





Applications

- Electronic Equipment

Features:

- Package: black epoxy

- ESD: 2 kV acc. to ANSI/ESDA/JEDEC JS-001 (HBM, Class 2)

- High optical power

- Very small package: (LxWxH) 3.2 mm x 1.6 mm x 1.85 mm

- Reverse mount

Ordering Information

Туре	Irradiance ¹⁾²⁾ $I_p = 70 \text{ mA}; t_p = 20 \text{ ms}$	Irradiance ¹⁾ typ. $I_{p} = 70 \text{ mA; } t_{p} = 20 \text{ ms}$	Ordering Code
	E _e	E _e	
SFH 4059R-RS	11.2 28.0 mW/cm ²	15 mW/cm ²	Q65112A2935

 E_a measured in the near field with a detector (7.2 mm diameter) in 20 mm distance (Ω = 0.1 sr) to the device surface



Maximum	Ratings
Maxilliulli	Naunys

$T_{\Lambda} = 25 ^{\circ}$)
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1 _A - 23 O			
Parameter	Symbol		Values
Operating temperature	T _{op}	min.	-40 °C
	ОР	max.	85 °C
Storage temperature	T _{stg}	min.	-40 °C
	5.69	max.	85 °C
Forward current	I _F	max.	70 mA
Forward current pulsed	 F pulse	max.	0.7 A
$t_p \le 300 \mu \text{s}; \ D \le 0.005$	i paloc		
Reverse voltage 3)	V_R	max.	5 V
Power consumption	P _{tot}	max.	140 mW
ESD withstand voltage	V _{ESD}	max.	2 kV
acc. to ANSI/ESDA/JEDEC JS-001 (HBM, Class 2)	LOD		



Characteristics

 I_F = 70 mA; t_p = 20 ms; T_A = 25 °C

Parameter	Symbol	Values	
Peak wavelength	λ_{peak}	typ.	860 nm
Centroid wavelength	$\lambda_{ ext{centroid}}$	typ.	850 nm
Spectral bandwidth at 50% I _{rel,max} (FWHM)	Δλ	typ.	30 nm
Half angle	φ	typ.	10 °
Dimensions of active chip area	L×W	typ.	0.2 x 0.2 mm x mm
Rise time (10% / 90%) $I_F = 70 \text{ mA}; R_L = 50 \Omega$	t _r	typ.	12 ns
Fall time (10% / 90%) $I_F = 70 \text{ mA}; R_L = 50 \Omega$	t _f	typ.	12 ns
Forward voltage 4)	V_{F}	typ. max.	1.6 V 1.9 V
Forward voltage $^{4)}$ I _F = 500 mA; t _p = 100 µs	V_{F}	typ. max.	2.4 V 2.9 V
Reverse current $^{3)}$ V _R = 5 V	I _R	typ. max.	0.01 μA 10 μA
Radiant intensity 5)	l _e	typ.	100 mW/sr
Total radiant flux ⁶⁾	Фе	typ.	40 mW
Temperature coefficient of voltage	TC _v	typ.	-0.7 mV / K
Temperature coefficient of brightness	TC _ı	typ.	-0.5 % / K
Temperature coefficient of wavelength	TC _λ	typ.	0.3 nm / K
Thermal resistance junction solder point real 7)	R _{thJS real}	max.	360 K / W
Thermal resistance junction ambient real 8)	R_{thJA}	max.	540 K / W



Brightness Groups

T_A = 25 °C

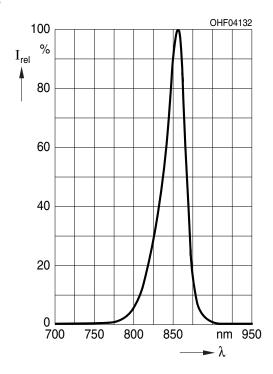
Group	Irradiance ¹⁾²⁾ $I_F = 70 \text{ mA}; t_p = 20 \text{ ms}$ min. E_e	Irradiance $^{1)2)}$ $I_F = 70 \text{ mA}; t_p = 20 \text{ ms}$ max. E_e
R	11.2 mW/cm ²	18.0 mW/cm²
S	18.0 mW/cm ²	28.0 mW/cm²

Only one group in one packing unit (variation lower 2:1).

 $E_{\rm e}$ measured in the near field with a detector (7.2 mm diameter) in 20 mm distance (Ω = 0.1 sr) to the device surface

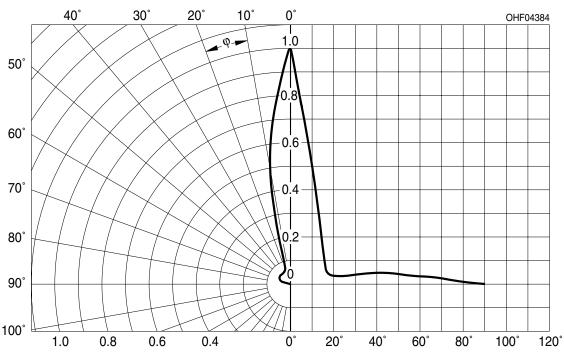
Relative Spectral Emission 9), 10)

$$I_{e,rel} = f(\lambda); I_F = 70 \text{ mA}; t_p = 20 \text{ ms}$$



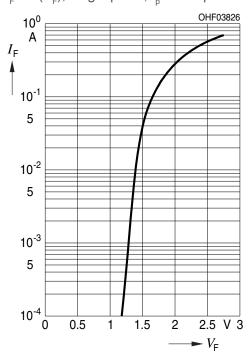
Radiation Characteristics 9), 10)

$$I_{e,rel} = f(\phi)$$



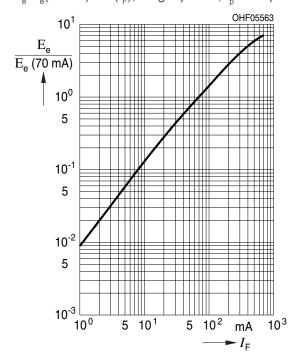
Forward current 9), 10)

 $I_F = f(V_F)$; single pulse; $t_D = 100 \mu s$



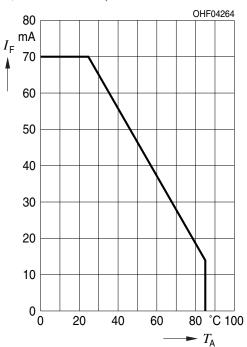
Irradiance 9), 10)

 $\rm E_e/E_e(70mA) = f(I_F);$ single pulse ; $\rm t_p = 25~\mu s$



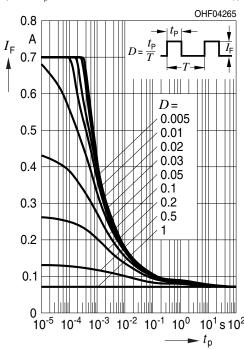
Max. Permissible Forward Current

$$I_{F,max} = f(T_A)$$
; Rth_{ja} = 540K / W



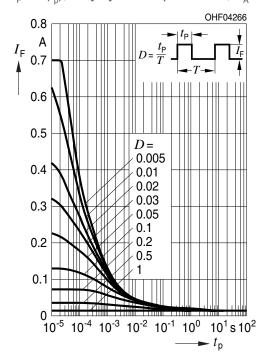
Permissible Pulse Handling Capability

 $I_F = f(t_p)$; duty cycle D = parameter; $T_A = 25$ °C

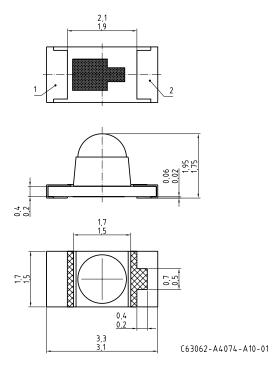


Permissible Pulse Handling Capability

 $I_F = f(t_p)$; duty cycle D = parameter; $T_A = 85$ °C



Dimensional Drawing 11)

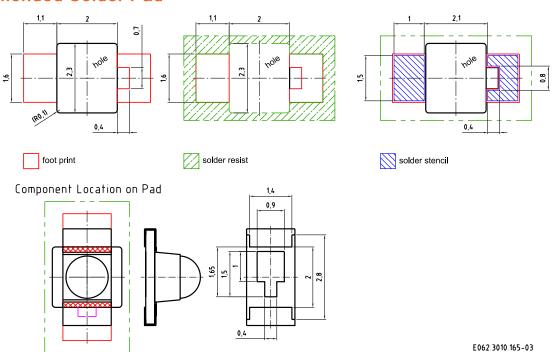


Further Information:

Approximate Weight: 8.0 mg

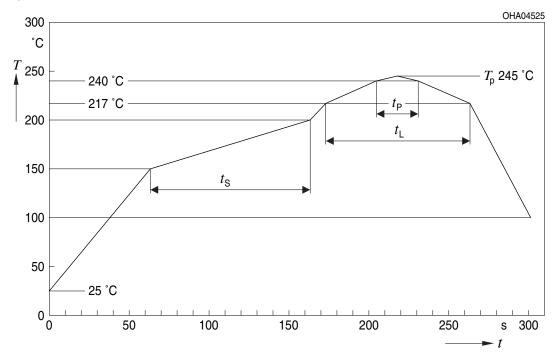
Pin	Description
1	Cathode
2	Anode

Recommended Solder Pad 11)



Reflow Soldering Profile

Product complies to MSL Level 3 acc. to JEDEC J-STD-020E



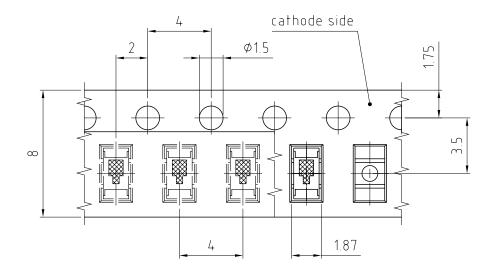
Profile Feature	Symbol	Pb	-Free (SnAgCu) Ass	sembly	Unit
		Minimum	Recommendation	Maximum	
Ramp-up rate to preheat*)			2	3	K/s
25 °C to 150 °C					
Time t _s	t_s	60	100	120	S
T_{Smin} to T_{Smax}					
Ramp-up rate to peak*)			2	3	K/s
T_{Smax} to T_{P}					
Liquidus temperature	T_L		217		°C
Time above liquidus temperature	$t_{\scriptscriptstyle \perp}$		80	100	S
Peak temperature	T_{P}		245	260	°C
Time within 5 °C of the specified peak	t _P	10	20	30	S
temperature T _P - 5 K					
Ramp-down rate*			3	6	K/s
T _P to 100 °C					
Time				480	S
25 °C to T _P					

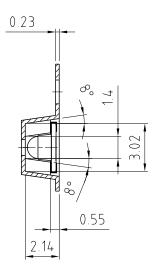
All temperatures refer to the center of the package, measured on the top of the component



^{*} slope calculation DT/Dt: Dt max. 5 s; fulfillment for the whole T-range

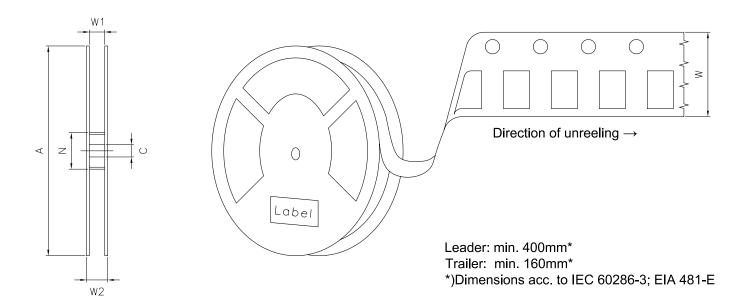
Taping 11)





C63062-A4074-B2-02

Tape and Reel 12)



Reel Dimensions

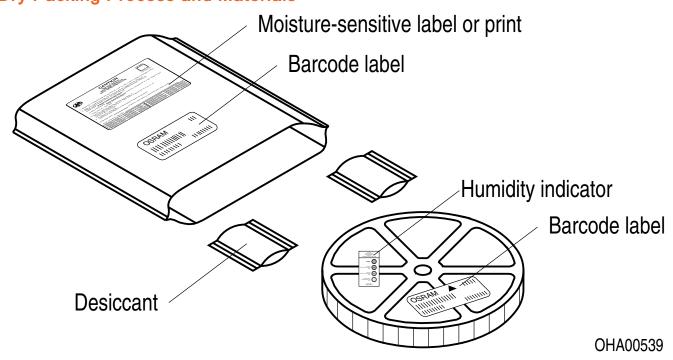
Α	W	N_{\min}	W_1	$W_{2 max}$	Pieces per PU
180 mm	8 + 0.3 / - 0.1 mm	60 mm	8.4 + 2 mm	14.4 mm	2000



Barcode-Product-Label (BPL)



Dry Packing Process and Materials 11)



Moisture-sensitive product is packed in a dry bag containing desiccant and a humidity card according JEDEC-STD-033.



Notes

The evaluation of eye safety occurs according to the standard IEC 62471:2006 (photo biological safety of lamps and lamp systems). Within the risk grouping system of this IEC standard, the device specified in this data sheet fall into the class **exempt group (exposure time 10000 s)**. Under real circumstances (for exposure time, conditions of the eye pupils, observation distance), it is assumed that no endangerment to the eye exists from these devices. As a matter of principle, however, it should be mentioned that intense light sources have a high secondary exposure potential due to their blinding effect. When looking at bright light sources (e.g. headlights), temporary reduction in visual acuity and afterimages can occur, leading to irritation, annoyance, visual impairment, and even accidents, depending on the situation.

Subcomponents of this device contain, in addition to other substances, metal filled materials including silver. Metal filled materials can be affected by environments that contain traces of aggressive substances. Therefore, we recommend that customers minimize device exposure to aggressive substances during storage, production, and use. Devices that showed visible discoloration when tested using the described tests above did show no performance deviations within failure limits during the stated test duration. Respective failure limits are described in the IEC60810.

For further application related information please visit www.osram-os.com/appnotes



Disclaimer

Attention please!

The information describes the type of component and shall not be considered as assured characteristics. Terms of delivery and rights to change design reserved. Due to technical requirements components may contain dangerous substances.

For information on the types in question please contact our Sales Organization.

If printed or downloaded, please find the latest version on the OSRAM OS website.

Packing

Please use the recycling operators known to you. We can also help you – get in touch with your nearest sales office. By agreement we will take packing material back, if it is sorted. You must bear the costs of transport. For packing material that is returned to us unsorted or which we are not obliged to accept, we shall have to invoice you for any costs incurred.

Product and functional safety devices/applications or medical devices/applications

OSRAM OS components are not developed, constructed or tested for the application as safety relevant component or for the application in medical devices.

OSRAM OS products are not qualified at module and system level for such application.

In case buyer – or customer supplied by buyer – considers using OSRAM OS components in product safety devices/applications or medical devices/applications, buyer and/or customer has to inform the local sales partner of OSRAM OS immediately and OSRAM OS and buyer and /or customer will analyze and coordinate the customer-specific request between OSRAM OS and buyer and/or customer.



Glossary

- Irradiance: Measured at a solid angle of $\Omega = 0.1 \text{ sr}$
- Brightness: The brightness values are measured with a tolerance of $\pm 11\%$.
- Reverse Operation: This product is intended to be operated applying a forward current within the specified range. Applying any continuous reverse bias or forward bias below the voltage range of light emission shall be avoided because it may cause migration which can change the electro-optical characteristics or damage the LED.
- Forward Voltage: The forward voltages are measured with a tolerance of ±0.1 V.
- Radiant intensity: Measured at a solid angle of Ω = 0.01 sr
- ⁶⁾ **Total radiant flux:** Measured with integrating sphere.
- Thermal resistance: junction soldering point, of the device only, mounted on an ideal heatsink (e.g. metal block)
- Thermal resistance: junction ambient, mounted on PC-board (FR4), padsize 5 mm² each
- Typical Values: Due to the special conditions of the manufacturing processes of semiconductor devices, the typical data or calculated correlations of technical parameters can only reflect statistical figures. These do not necessarily correspond to the actual parameters of each single product, which could differ from the typical data and calculated correlations or the typical characteristic line. If requested, e.g. because of technical improvements, these typ. data will be changed without any further notice.
- Testing temperature: TA = 25°C (unless otherwise specified)
- Tolerance of Measure: Unless otherwise noted in drawing, tolerances are specified with ±0.1 and dimensions are specified in mm.
- 12) **Tape and Reel:** All dimensions and tolerances are specified acc. IEC 60286-3 and specified in mm.



SFH 4059R

Revision History				
Version	Date	Change		
1.2	2020-03-16	Ordering Information Characteristics Schematic Transportation Box Dimensions of Transportation Box		
1.3	2020-03-18	Ordering Information		
1.4	2021-09-30	Brand		



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